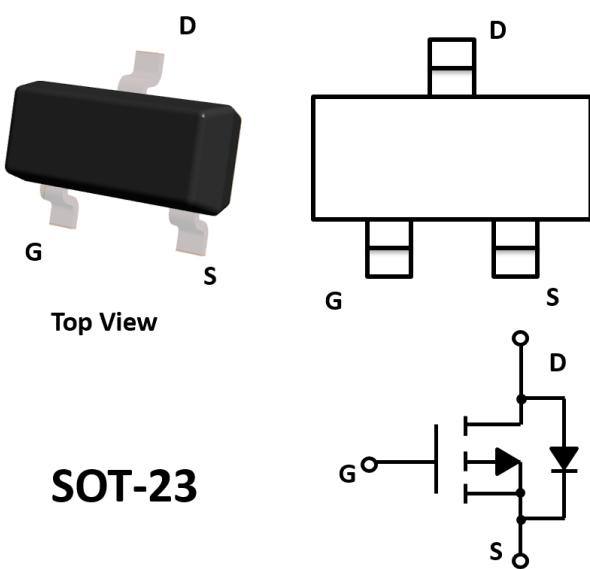


P-Channel Enhancement Mode Field Effect Transistor



Product Summary

- V_{DS} -12V
- I_D -6A
- $R_{DS(ON)}$ (at $V_{GS}=-4.5V$) <40 mohm
- $R_{DS(ON)}$ (at $V_{GS}=-2.5V$) <50 mohm
- $R_{DS(ON)}$ (at $V_{GS}=-1.8V$) <70 mohm

General Description

- Trench Power LV MOSFET technology
- High Density Cell Design for Low $R_{DS(ON)}$
- High Speed switching

Applications

- Battery protection
- Load switch
- Power management

■ Absolute Maximum Ratings ($T_A=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Maximum	Unit
Drain-source Voltage	V_{DS}	-12	V
Gate-source Voltage	V_{GS}	± 8	V
Drain Current	I_D	-6	A
Pulsed Drain Current ^A	I_{DM}	-20	A
Total Power Dissipation @ $T_A=25^\circ\text{C}$ Steady State	P_D	1.2	W
Thermal Resistance Junction-to-Ambient @ Steady State ^B	$R_{\theta JA}$	104	$^\circ\text{C} / \text{W}$
Junction and Storage Temperature Range	T_J, T_{STG}	-55~+150	$^\circ\text{C}$

■ Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Static Parameter						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=-250\mu\text{A}$	-12			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}}=-12\text{V}, V_{\text{GS}}=0\text{V}, T_c=25^\circ\text{C}$			-1	μA
Gate-Body Leakage Current	I_{GSS}	$V_{\text{GS}}= \pm 8\text{V}, V_{\text{DS}}=0\text{V}$			± 100	nA
Gate Threshold Voltage	$V_{\text{GS(th)}}$	$V_{\text{DS}}= V_{\text{GS}}, I_{\text{D}}=-250\mu\text{A}$	-0.4	-0.6	-1.0	V
Static Drain-Source On-Resistance	$R_{\text{DS(ON)}}$	$V_{\text{GS}}= -4.5\text{V}, I_{\text{D}}=-5.4\text{A}$		30	40	$\text{m}\Omega$
		$V_{\text{GS}}= -2.5\text{V}, I_{\text{D}}=-4.0\text{A}$		37	50	
		$V_{\text{GS}}= -1.8\text{V}, I_{\text{D}}=-1.0\text{A}$		58	70	
Diode Forward Voltage	V_{SD}	$I_{\text{S}}=-4\text{A}, V_{\text{GS}}=0\text{V}$		-0.8	-1.2	V
Maximum Body-Diode Continuous Current	I_{S}				-6	A
Dynamic Parameters						
Input Capacitance	C_{iss}	$V_{\text{DS}}=-4\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$		740		pF
Output Capacitance	C_{oss}			290		
Reverse Transfer Capacitance	C_{rss}			190		
Switching Parameters						
Total Gate Charge	Q_{g}	$V_{\text{GS}}=-2.5\text{V}, V_{\text{DS}}=-4\text{V}, I_{\text{D}}=-4\text{A}$		4.5		nC
Gate Source Charge	Q_{gs}			1.2		
Gate Drain Charge	Q_{gd}			1.6		
Turn-on Delay Time	$t_{\text{D(on)}}$	$V_{\text{GEN}}=-8\text{V}, V_{\text{DD}}=-4\text{V}, R_{\text{L}}=1.2\Omega, I_{\text{D}}=-3.3\text{A}$		5		ns
Turn-on Rise Time	t_{r}			11		
Turn-off Delay Time	$t_{\text{D(off)}}$			22		
Turn-off Fall Time	t_{f}			16		

A. Pulse Test: Pulse Width $\leq 300\text{us}$, Duty cycle $\leq 2\%$.

B. Device mounted on FR-4 PCB, 1 inch x 0.85 inch x 0.062 inch.

■ Typical Performance Characteristics

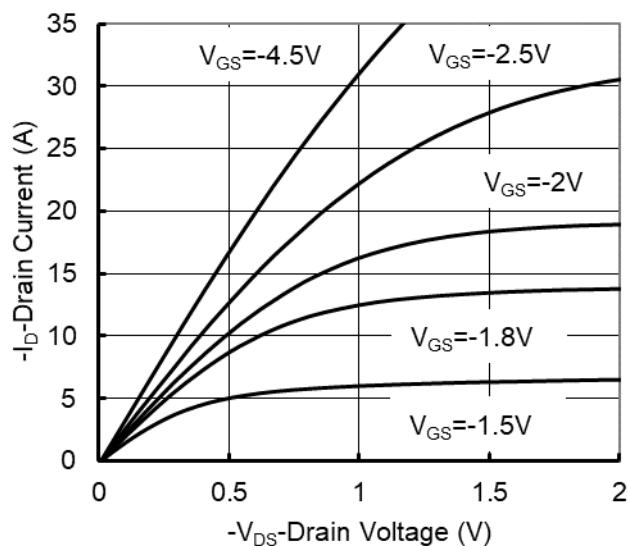


Figure 1. Output Characteristics

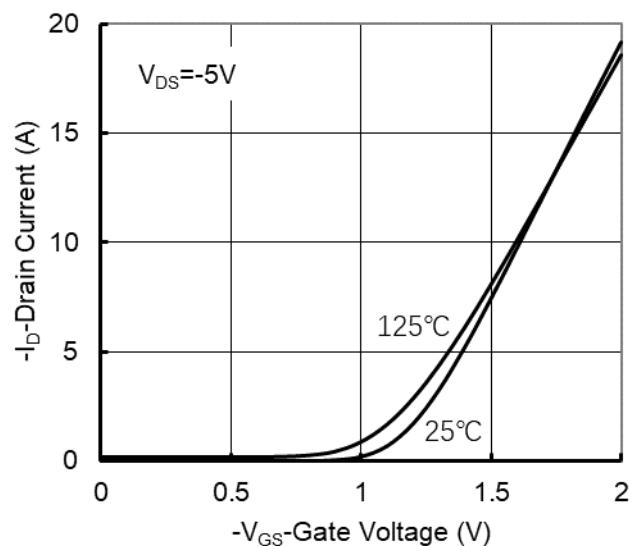


Figure 2. Transfer Characteristics

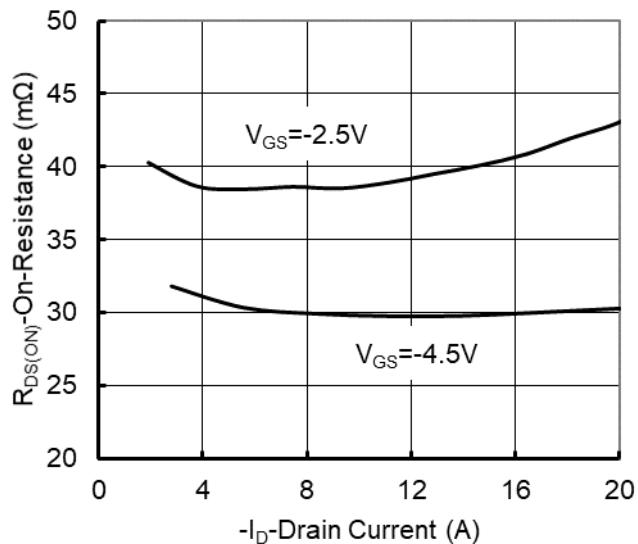


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

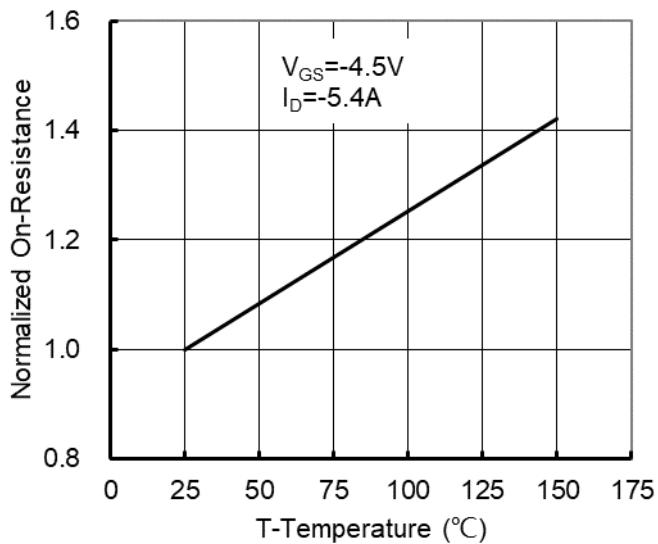


Figure 4: On-Resistance vs. Junction Temperature

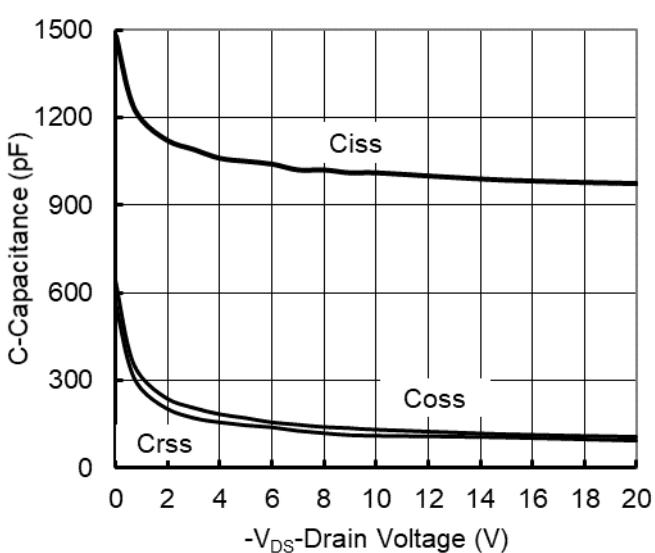


Figure 5. Capacitance Characteristics

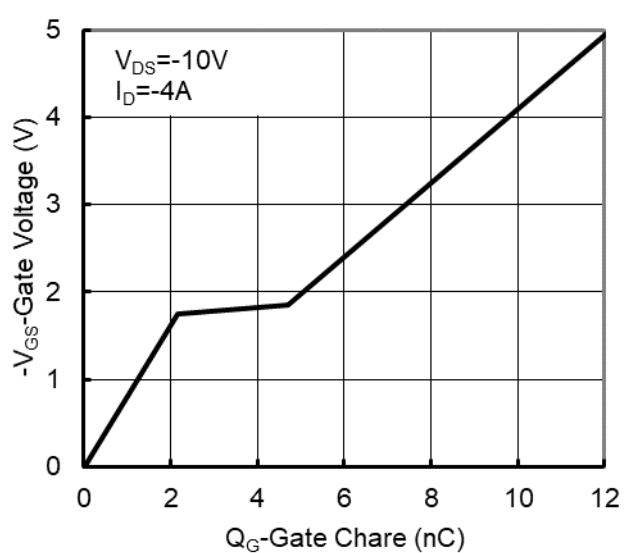


Figure 6. Gate Charge

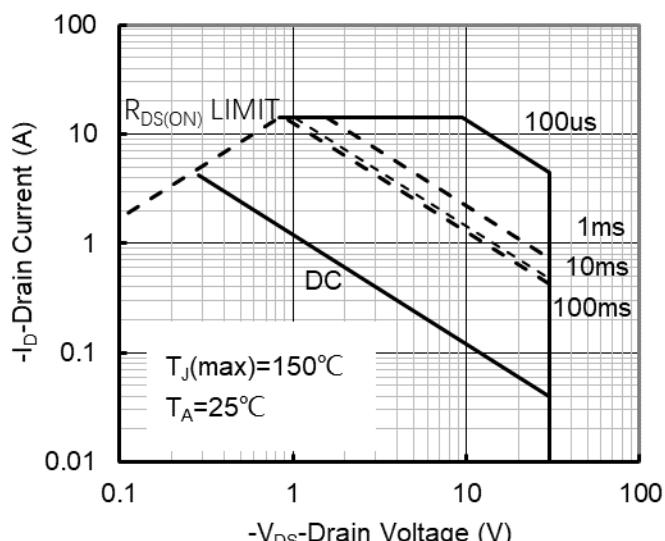


Figure7. Safe Operation Area

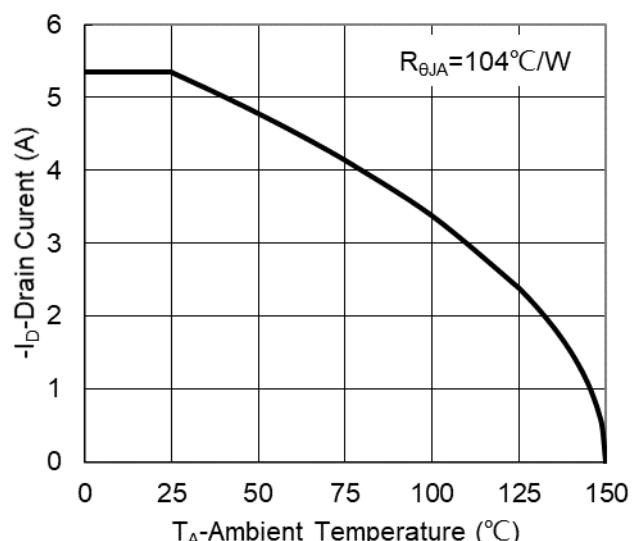
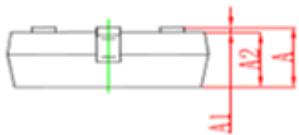
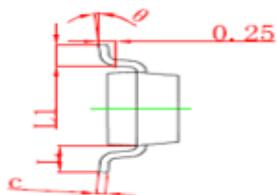
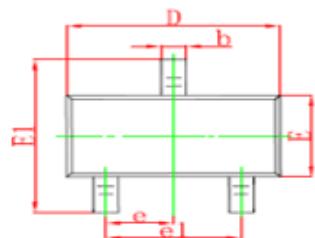


Figure8. Maximum Continuous Drain Current
vs Ambient Temperature

■ SOT-23 Package information

Symbol	Dimensions in Millimeter		Dimensions in Inches	
	Min	Max	Min	Max
A	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
c	0.100	0.200	0.004	0.008
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
e	0.950Type		0.037Type	
e1	1.800	2.000	0.071	0.079
L	0.550REF		0.220REF	
L1	0.300	0.500	0.012	0.020
θ	0 °	8 °	0 °	8 °

■ SOT-23 Suggested Pad Layout